

Vishay Siliconix

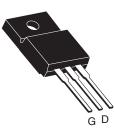
RoHS

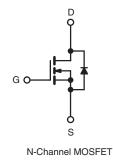
COMPLIANT

Power MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	200				
R _{DS(on)} (Ω)	V _{GS} = 10 V	0.18			
Q _g (Max.) (nC)	70				
Q _{gs} (nC)	13				
Q _{gd} (nC)	39				
Configuration	Single				

TO-220 FULLPAK





FEATURES

- Isolated Package
- High Voltage Isolation = 2.5 kV_{RMS} (t = 60 s; f = 60 Hz)
- Sink to Lead Creepage Distance = 4.8 mm
- Dynamic dV/dt Rating
- · Low Thermal Resistance
- Lead (Pb)-free Available

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 FULLPAK eliminates the need for additional insulating hardware in commercial-industrial applications. The molding compound used provides a high isolation capability and a low thermal resistance between the tab and external heatsink. The isolation is equivalent to using a 100 micron mica barrier with standard TO-220 product. The FULLPAK is mounted to a heatsink using a single clip or by a single screw fixing.

ORDERING INFORMATION	
Package	TO-220 FULLPAK
Lead (Pb)-free	IRFI640GPbF
	SiHFI640G-E3
SnPb	IRFI640G
	SiHFI640G

ABSOLUTE MAXIMUM RATINGS $T_C = 25 \text{ °C}$, unless otherwise noted							
PARAMETER			SYMBOL	LIMIT	UNIT		
Drain-Source Voltage			V _{DS}	200	v		
Gate-Source Voltage			V _{GS}	± 20			
Continuous Drain Current	V_{GS} at 10 V $T_C = 25 \degree C$	T _C = 25 °C	۱ _D	9.8			
	VGS AL TO V	$T_{C} = 25 \text{ °C}$ $T_{C} = 100 \text{ °C}$		6.2	А		
Pulsed Drain Current ^a			I _{DM}	39			
Linear Derating Factor				0.32	W/°C		
Single Pulse Avalanche Energy ^b			E _{AS}	430	mJ		
Repetitive Avalanche Current ^a			I _{AR} 9.8		А		
Repetitive Avalanche Energy ^a			E _{AR}	4.0	mJ		
Maximum Power Dissipation	T _C = 25 °C		T _C = 25 °C		PD	40	W
Peak Diode Recovery dV/dtc			dV/dt	5.0	V/ns		
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to + 150	°C			
Soldering Recommendations (Peak Temperature)	for 10	S		300 ^d	C		
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in		
				1.1	N · m		

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. V_{DD} = 50 V, starting T_J = 25 °C, L = 6.7 mH, R_G = 25 Ω , I_{AS} = 9.8 A (see fig. 12).

c. $I_{SD} \leq 18$ A, $dI/dt \leq 150$ A/µs, $V_{DD} \leq V_{DS}, \, T_J \leq 150 \ ^{\circ}C.$

d. 1.6 mm from case.

* Pb containing terminations are not RoHS compliant, exemptions may apply

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PARAMETER	SYMBOL	TYP. MAX.			UNIT			
Maximum Junction-to-Ambient	R _{thJA}	- 65 - 3.1						
Maximum Junction-to-Case (Drain)	R _{thJC}				°C/W			
	1100							
SPECIFICATIONS T _J = 25 °C, 1	unless otherv	vise noted						
PARAMETER	SYMBOL		T CONDITI	ONS	MIN.	TYP.	MAX.	UNIT
Static								1
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} =	= 0 V, I _D = 2	50 µA	200	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_J$	Reference	e to 25 °C,	I _D = 1 mA	-	0.29	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	= V _{GS} , I _D = 2	250 μΑ	2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}	,	V _{GS} = ± 20 V			-	± 100	nA
		V _{DS} =	= 200 V, V _G s	s = 0 V	-	-	25	
Zero Gate Voltage Drain Current	IDSS	V _{DS} = 160 V	′, V _{GS} = 0 V) V, T _J = 125 °C			250	μΑ
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D	= 5.9 A ^b	-	-	0.18	Ω
Forward Transconductance	g _{fs}	V _{DS} =	= 50 V, I _D =	5.9 A ^b	5.2	-	-	S
Dynamic		•						•
Input Capacitance	C _{iss}	V _{GS} = 0 V,			-	1300	-	pF
Output Capacitance	Coss	$V_{GS} = 0.7$, $V_{DS} = 25$ V, f = 1.0 MHz, see fig. 5		-	400	-		
Reverse Transfer Capacitance	C _{rss}			-	130	-		
Drain to Sink Capacitance	С		f = 1.0 MHz		-	12	-	1
Total Gate Charge	Qg			-	-	70	nC	
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V	$V_{GS} = 10 \text{ V} \qquad I_D = 18 \text{ A}, V_{DS} = 160 \text{ V}, \\ \text{see fig. 6 and } 13^{\text{b}}$		-	-		13
Gate-Drain Charge	Q _{gd}				-	-		39
Turn-On Delay Time	t _{d(on)}				-	14	-	
Rise Time	t _r		= 100 V, I _D =		-	51	-	1
Turn-Off Delay Time	t _{d(off)}	R _G = 9.1 Ω, R _D = 5.4 Ω, see fig. 10 ^b		-	45	-	ns	
Fall Time	t _f			-	36	-		
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	nH	
Internal Source Inductance	L _S			-	7.5	-		
Drain-Source Body Diode Characteristic	s	•						
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	9.8	A	
Pulsed Diode Forward Current ^a	I _{SM}			-	-	39		
Body Diode Voltage	V_{SD}	$T_J = 25 \ ^\circ C, \ I_S = 9.8 \ A, \ V_{GS} = 0 \ V^b$		-	-	2.0	V	
Body Diode Reverse Recovery Time	t _{rr}	$T_J = 25 \text{ °C}, I_F = 18 \text{ A}, dI/dt = 100 \text{ A}/\mu\text{s}^b$		-	300	610	ns	
Body Diode Reverse Recovery Charge	Q _{rr}			-	3.4	7.1	μC	
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L_S and L_D)						_D)

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width \leq 300 µs; duty cycle \leq 2



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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

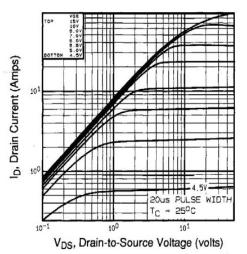


Fig. 1 - Typical Output Characteristics, T_C= 25 °C

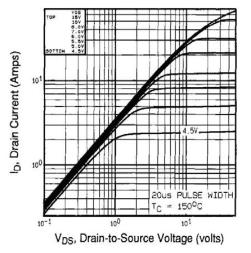
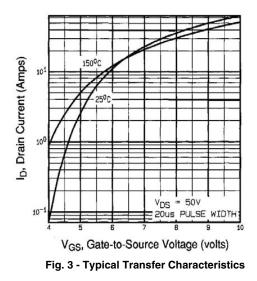


Fig. 2 - Typical Output Characteristics, T_C = 150 °C



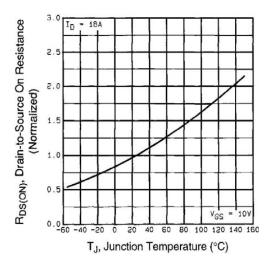


Fig. 4 - Normalized On-Resistance vs. Temperature

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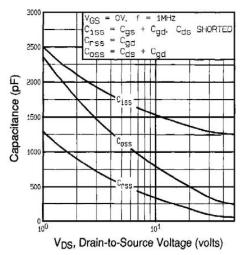


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

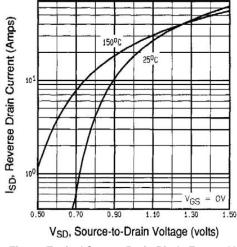


Fig. 7 - Typical Source-Drain Diode Forward Voltage

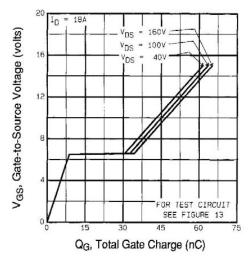


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

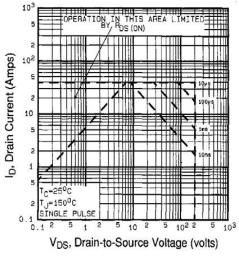


Fig. 8 - Maximum Safe Operating Area



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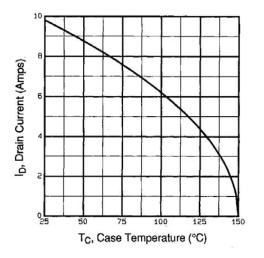


Fig. 9 - Maximum Drain Current vs. Case Temperature

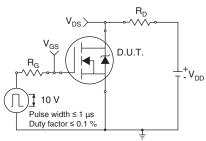


Fig. 10a - Switching Time Test Circuit

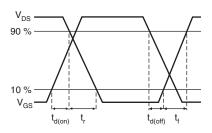
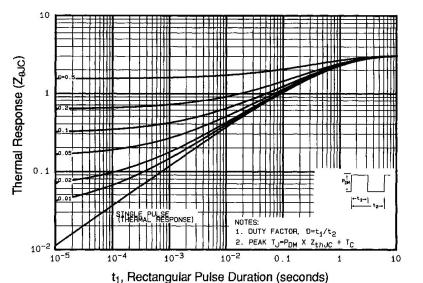
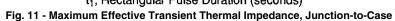


Fig. 10b - Switching Time Waveforms





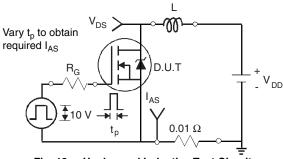


Fig. 12a - Unclamped Inductive Test Circuit

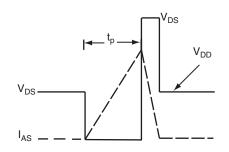


Fig. 12b - Unclamped Inductive Waveforms

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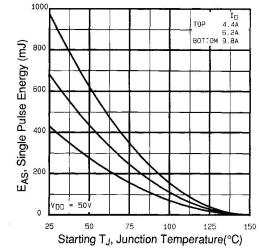


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

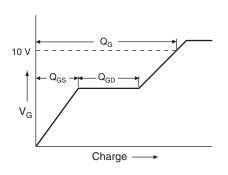


Fig. 13a - Basic Gate Charge Waveform

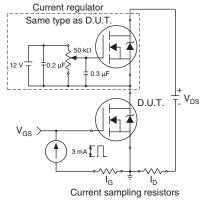
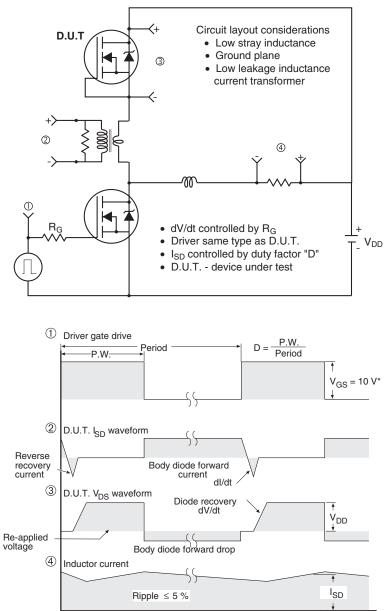


Fig. 13b - Gate Charge Test Circuit



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Peak Diode Recovery dV/dt Test Circuit

* $V_{GS} = 5 V$ for logic level devices

Fig. 14 - For N-Channel

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